



# RF Power Field Effect Transistors

## N-Channel Enhancement-Mode Lateral MOSFETs

Designed for CDMA base station applications with frequencies from 790 to 895 MHz. Can be used in Class AB and Class C for all typical cellular base station modulation formats.

- Typical Single-Carrier W-CDMA Performance:  $V_{DD} = 28$  Volts,  $I_{DQ} = 1500$  mA,  $P_{out} = 70$  Watts Avg., IQ Magnitude Clipping, Channel Bandwidth = 3.84 MHz, Input Signal PAR = 7.5 dB @ 0.01% Probability on CCDF.

Frequency	$G_{ps}$ (dB)	$\eta_D$ (%)	Output PAR (dB)	ACPR (dBc)
850 MHz	21.3	36.2	6.5	-37.0
875 MHz	21.4	37.4	6.3	-36.7
895 MHz	21.1	37.5	6.2	-36.9

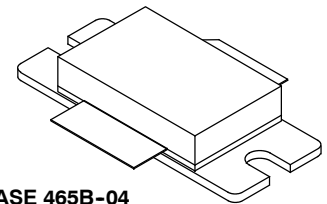
- Capable of Handling 7:1 VSWR, @ 32 Vdc, 875 MHz, 390 Watts CW <sup>(1)</sup> Output Power (3 dB Input Overdrive from Rated  $P_{out}$ ), Designed for Enhanced Ruggedness
- Typical  $P_{out}$  @ 1 dB Compression Point  $\approx$  260 Watts CW <sup>(1)</sup>

### Features

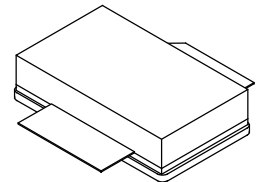
- 100% PAR Tested for Guaranteed Output Power Capability
- Characterized with Series Equivalent Large-Signal Impedance Parameters and Common Source S-Parameters
- Internally Matched for Ease of Use
- Integrated ESD Protection
- Greater Negative Gate-Source Voltage Range for Improved Class C Operation
- Designed for Digital Predistortion Error Correction Systems
- Optimized for Doherty Applications
- In Tape and Reel. R3 Suffix = 250 Units, 56 mm Tape Width, 13 inch Reel. For R5 Tape and Reel option, see p. 16.

**MRF8S8260HR3**  
**MRF8S8260HSR3**

**850-895 MHz, 70 W AVG. 28 V**  
**SINGLE W-CDMA**  
**LATERAL N-CHANNEL**  
**RF POWER MOSFETs**



**CASE 465B-04**  
**NI-880**  
**MRF8S8260HR3**



**CASE 465C-03**  
**NI-880S**  
**MRF8S8260HSR3**

**Table 1. Maximum Ratings**

Rating	Symbol	Value	Unit
Drain-Source Voltage	$V_{DSS}$	-0.5, +70	Vdc
Gate-Source Voltage	$V_{GS}$	-6.0, +10	Vdc
Operating Voltage	$V_{DD}$	32, +0	Vdc
Storage Temperature Range	$T_{stg}$	-65 to +150	°C
Case Operating Temperature	$T_C$	150	°C
Operating Junction Temperature <sup>(2,3)</sup>	$T_J$	225	°C
CW Operation @ $T_C = 25^\circ\text{C}$ Derate above 25°C	CW	201 0.94	W W/°C

**Table 2. Thermal Characteristics**

Characteristic	Symbol	Value <sup>(3,4)</sup>	Unit
Thermal Resistance, Junction to Case Case Temperature 83°C, 70 W CW, 28 Vdc, $I_{DQ} = 1500$ mA, 895 MHz Case Temperature 80°C, 260 W CW <sup>(1)</sup> , 28 Vdc, $I_{DQ} = 1500$ mA, 895 MHz	$R_{\theta JC}$	0.36 0.31	°C/W

1. Exceeds recommended operating conditions. See CW operation data in Maximum Ratings table.
2. Continuous use at maximum temperature will affect MTTF.
3. MTTF calculator available at <http://www.freescale.com/rf>. Select Software & Tools/Development Tools/Calculators to access MTTF calculators by product.
4. Refer to AN1955, *Thermal Measurement Methodology of RF Power Amplifiers*. Go to <http://www.freescale.com/rf>. Select Documentation/Application Notes - AN1955.

**Table 3. ESD Protection Characteristics**

Test Methodology	Class
Human Body Model (per JESD22-A114)	2
Machine Model (per EIA/JESD22-A115)	A
Charge Device Model (per JESD22-C101)	IV

**Table 4. Electrical Characteristics** ( $T_A = 25^\circ\text{C}$  unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
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**Off Characteristics**

Zero Gate Voltage Drain Leakage Current ( $V_{DS} = 70\text{ Vdc}$ , $V_{GS} = 0\text{ Vdc}$ )	$I_{DSS}$	—	—	10	$\mu\text{Adc}$
Zero Gate Voltage Drain Leakage Current ( $V_{DS} = 28\text{ Vdc}$ , $V_{GS} = 0\text{ Vdc}$ )	$I_{DSS}$	—	—	1	$\mu\text{Adc}$
Gate-Source Leakage Current ( $V_{GS} = 5\text{ Vdc}$ , $V_{DS} = 0\text{ Vdc}$ )	$I_{GSS}$	—	—	1	$\mu\text{Adc}$

**On Characteristics**

Gate Threshold Voltage ( $V_{DS} = 10\text{ Vdc}$ , $I_D = 1380\ \mu\text{Adc}$ )	$V_{GS(th)}$	1.5	2.3	3.0	Vdc
Gate Quiescent Voltage ( $V_{DD} = 28\text{ Vdc}$ , $I_D = 1500\ \text{mAdc}$ , Measured in Functional Test)	$V_{GS(Q)}$	2.3	3.0	3.8	Vdc
Drain-Source On-Voltage ( $V_{GS} = 10\text{ Vdc}$ , $I_D = 3.0\ \text{Adc}$ )	$V_{DS(on)}$	0.1	0.24	0.3	Vdc

**Functional Tests** <sup>(1)</sup> (In Freescale Test Fixture, 50 ohm system)  $V_{DD} = 28\text{ Vdc}$ ,  $I_{DQ} = 1500\ \text{mA}$ ,  $P_{out} = 70\ \text{W Avg.}$ ,  $f = 895\ \text{MHz}$ , Single-Carrier W-CDMA, IQ Magnitude Clipping, Input Signal PAR = 7.5 dB @ 0.01% Probability on CCDF. ACPR measured in 3.84 MHz Channel Bandwidth @  $\pm 5\ \text{MHz}$  Offset.

Power Gain	$G_{ps}$	19.6	21.1	22.6	dB
Drain Efficiency	$\eta_D$	35.5	37.5	—	%
Output Peak-to-Average Ratio @ 0.01% Probability on CCDF	PAR	5.8	6.2	—	dB
Adjacent Channel Power Ratio	ACPR	—	-36.9	-35.0	dBc
Input Return Loss	IRL	—	-16	-12	dB

**Typical Broadband Performance** (In Freescale Test Fixture, 50 ohm system)  $V_{DD} = 28\text{ Vdc}$ ,  $I_{DQ} = 1500\ \text{mA}$ ,  $P_{out} = 70\ \text{W Avg.}$ , Single-Carrier W-CDMA, IQ Magnitude Clipping, Input Signal PAR = 7.5 dB @ 0.01% Probability on CCDF. ACPR measured in 3.84 MHz Channel Bandwidth @  $\pm 5\ \text{MHz}$  Offset.

Frequency	$G_{ps}$ (dB)	$\eta_D$ (%)	Output PAR (dB)	ACPR (dBc)	IRL (dB)
850 MHz	21.3	36.2	6.5	-37.0	-9
875 MHz	21.4	37.4	6.3	-36.7	-13
895 MHz	21.1	37.5	6.2	-36.9	-16

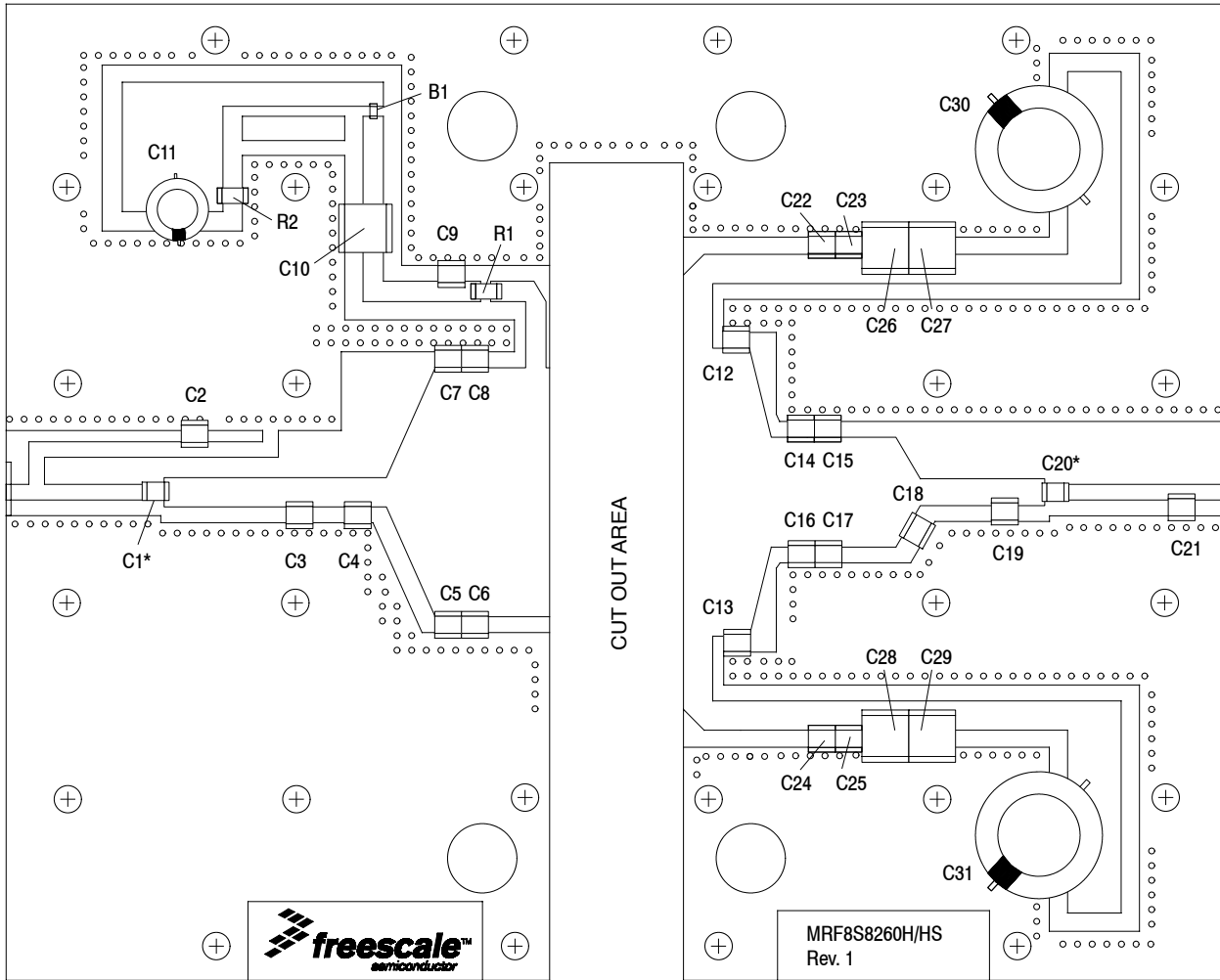
1. Part internally matched both on input and output.

(continued)

**Table 4. Electrical Characteristics** ( $T_A = 25^\circ\text{C}$  unless otherwise noted) **(continued)**

Characteristic	Symbol	Min	Typ	Max	Unit
<b>Typical Performance</b> (In Freescale Test Fixture, 50 ohm system) $V_{DD} = 28$ Vdc, $I_{DQ} = 1500$ mA, 850-895 MHz Bandwidth					
$P_{out}$ @ 1 dB Compression Point, CW	P1dB	—	260 <sup>(1)</sup>	—	W
IMD Symmetry @ 80 W PEP, $P_{out}$ where IMD Third Order Intermodulation $\cong 30$ dBc (Delta IMD Third Order Intermodulation between Upper and Lower Sidebands > 2 dB)	IMD <sub>sym</sub>	—	9.7	—	MHz
VBW Resonance Point (IMD Third Order Intermodulation Inflection Point)	VBW <sub>res</sub>	—	60	—	MHz
Gain Flatness in 45 MHz Bandwidth @ $P_{out} = 70$ W Avg.	G <sub>F</sub>	—	0.3	—	dB
Gain Variation over Temperature (-30°C to +85°C)	$\Delta G$	—	0.016	—	dB/°C
Output Power Variation over Temperature (-30°C to +85°C) <sup>(1)</sup>	$\Delta P_{1dB}$	—	0.002	—	dB/°C

1. Exceeds recommended operating conditions. See CW operation data in Maximum Ratings table.



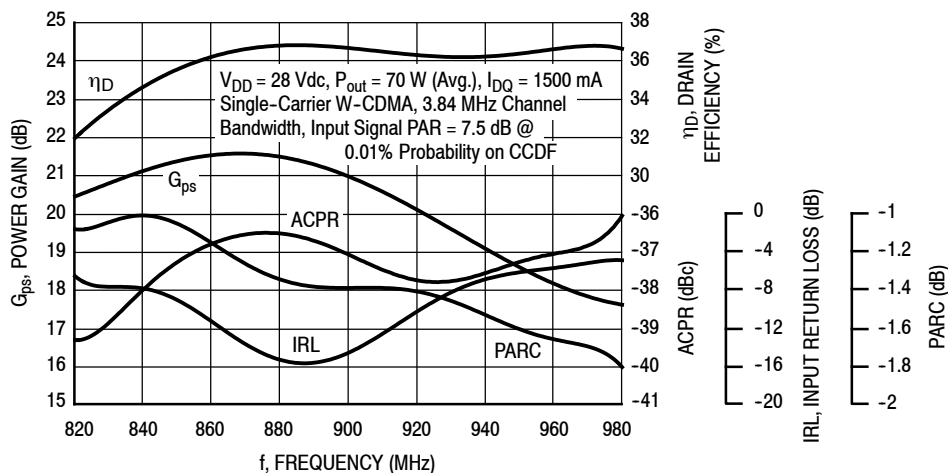
\*C1 and C20 are mounted vertically.

Figure 1. MRF8S8260HR3(HSR3) Test Circuit Component Layout

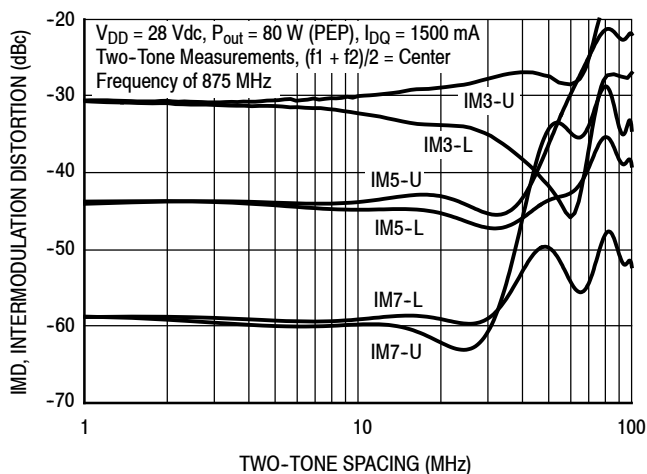
Table 5. MRF8S8260HR3(HSR3) Test Circuit Component Designations and Values

Part	Description	Part Number	Manufacturer
B1	RF Bead	BLM21PG300SN1D	Murata
C1	2.7 pF Chip Capacitor	ATC100B2R7BT500XT	ATC
C2	100 pF Chip Capacitor	ATC100B101JT500XT	ATC
C3	2.4 pF Chip Capacitor	ATC100B2R4JT500XT	ATC
C4	5.1 pF Chip Capacitor	ATC100B5R1CT500XT	ATC
C5 C7	3.3 pF Chip Capacitors	ATC100B3R3CT500XT	ATC
C6, C8	3.9 pF Chip Capacitors	ATC100B3R9CT500XT	ATC
C9, C20, C22, C23, C24, C25	43 pF Chip Capacitors	ATC100B430JT500XT	ATC
C10	4.7 $\mu$ F, 100 V Chip Capacitor	GRM55ER72A475KAO1B	Murata
C11	22 $\mu$ F Electrolytic Capacitor	UUD1V220MCL1GS	Nichicon
C12, C13	8.2 pF Chip Capacitors	ATC100B8R2CT500XT	ATC
C14, C16	3.9 pF Chip Capacitors	ATC100B3R9CT500XT	ATC
C15, C17	3.0 pF Chip Capacitors	ATC100B3R0CT500XT	ATC
C18	0.7 pF Chip Capacitor	ATC100B0R7BT500XT	ATC
C19	4.3 pF Chip Capacitor	ATC100B4R3CT500XT	ATC
C21	0.1 pF Chip Capacitor	ATC100B0R1BT500XT	ATC
C26, C27, C28, C29	10 $\mu$ F, 50 V Chip Capacitors	GRM55DR61H106KA88L	Murata
C30, C31	470 $\mu$ F Electrolytic Capacitors	MCGPR63V477M13X26-RH	Multicomp
R1	2.0 $\Omega$ , 1/4 W Chip Resistor	P2.0VCT-ND	Panasonic
R2	1 K $\Omega$ , 1/4 W Chip Resistor	CRCW12061K00FKEA	Vishay
PCB	0.030", $\epsilon_r = 3.5$	TC350	Arlon

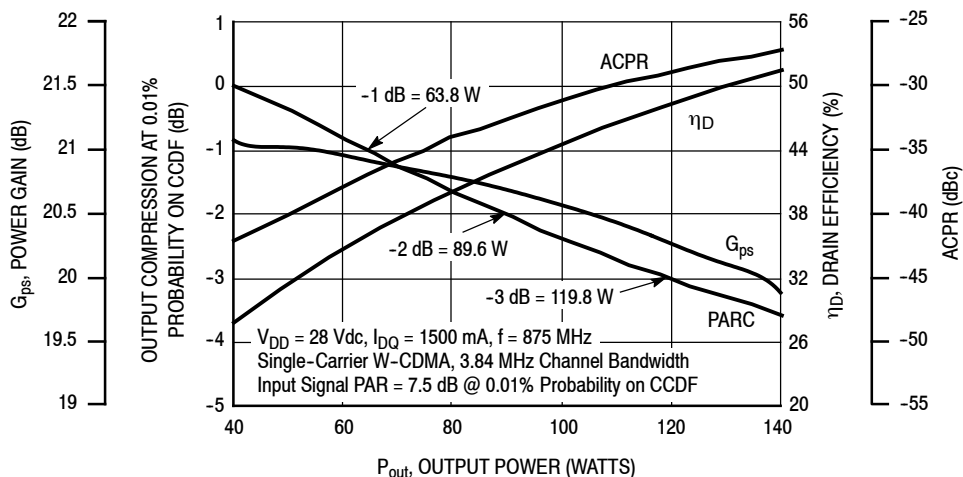
### TYPICAL CHARACTERISTICS



**Figure 2. Output Peak-to-Average Ratio Compression (PARC) Broadband Performance @ P<sub>out</sub> = 70 Watts Avg.**



**Figure 3. Intermodulation Distortion Products versus Two-Tone Spacing**



**Figure 4. Output Peak-to-Average Ratio Compression (PARC) versus Output Power**

## TYPICAL CHARACTERISTICS

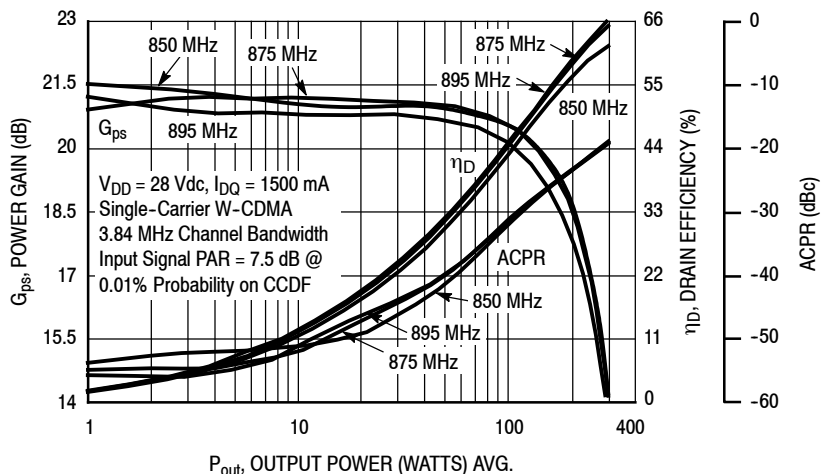


Figure 5. Single-Carrier W-CDMA Power Gain, Drain Efficiency and ACPR versus Output Power

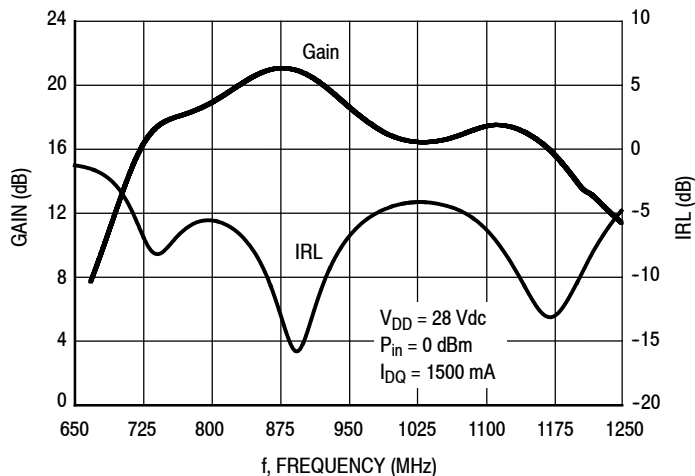


Figure 6. Broadband Frequency Response

## W-CDMA TEST SIGNAL

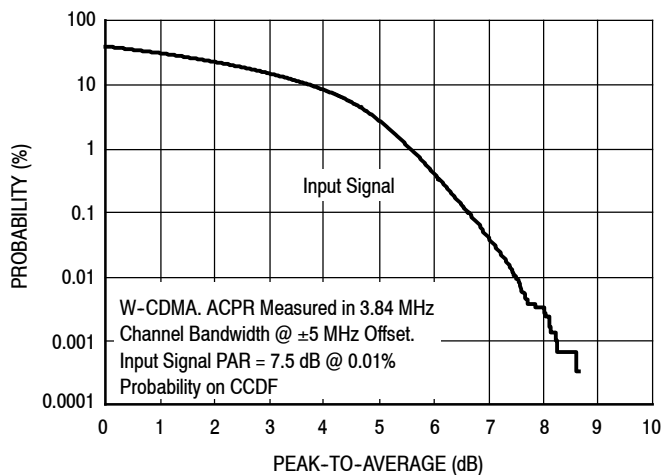


Figure 7. CCDF W-CDMA IQ Magnitude Clipping, Single-Carrier Test Signal

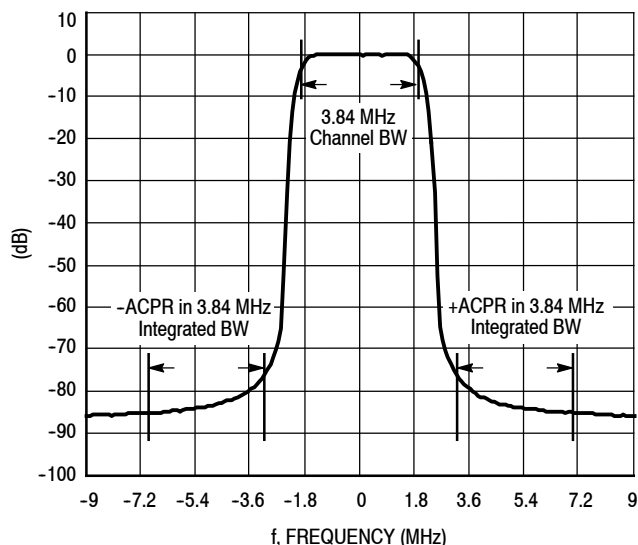


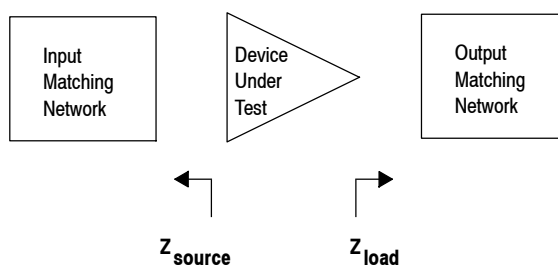
Figure 8. Single-Carrier W-CDMA Spectrum

$V_{DD} = 28 \text{ Vdc}$ ,  $I_{DQ} = 1500 \text{ mA}$ ,  $P_{out} = 70 \text{ W Avg.}$

f MHz	$Z_{source}$ $\Omega$	$Z_{load}$ $\Omega$
820	3.19 - j1.47	1.38 - j0.80
840	2.98 - j1.61	1.37 - j0.52
860	2.78 - j1.75	1.38 - j0.29
880	2.50 - j1.87	1.44 - j0.14
900	2.20 - j1.92	1.48 - j0.01
920	1.96 - j1.79	1.52 + j0.12
940	1.82 - j1.58	1.59 + j0.32
960	1.74 - j1.35	1.68 + j0.51
980	1.68 - j1.12	1.77 + j0.61

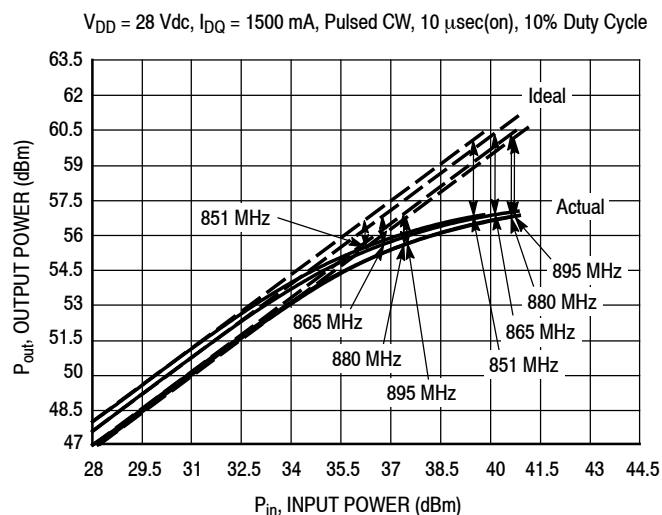
$Z_{source}$  = Test circuit impedance as measured from gate to ground.

$Z_{load}$  = Test circuit impedance as measured from drain to ground.



**Figure 9. Series Equivalent Source and Load Impedance**

## ALTERNATIVE PEAK TUNE LOAD PULL CHARACTERISTICS



f (MHz)	P1dB		P3dB	
	Watts	dBm	Watts	dBm
851	359	55.5	482	56.8
865	366	55.6	485	56.9
880	362	55.6	477	56.8
895	365	55.6	478	56.8

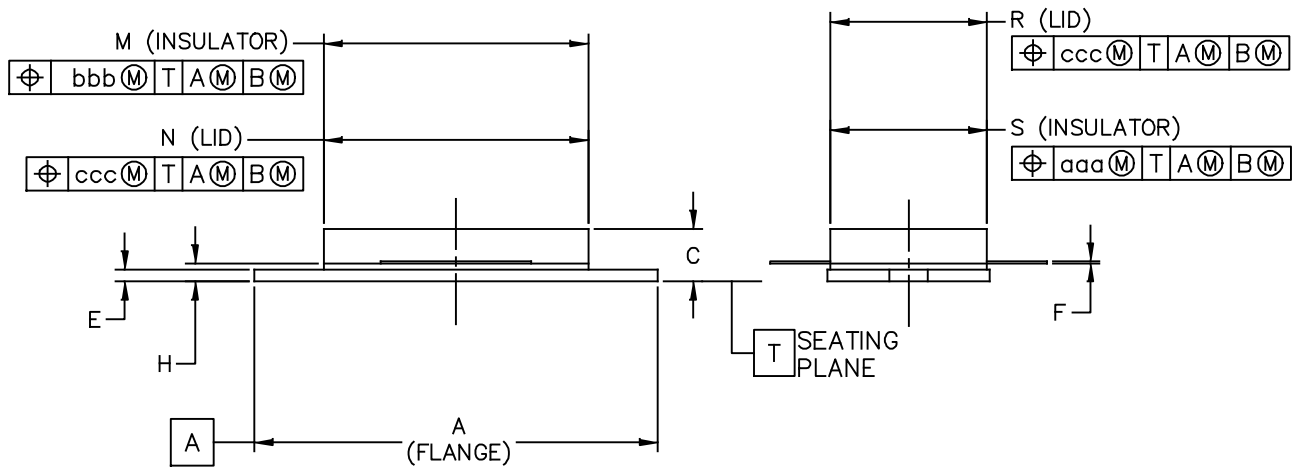
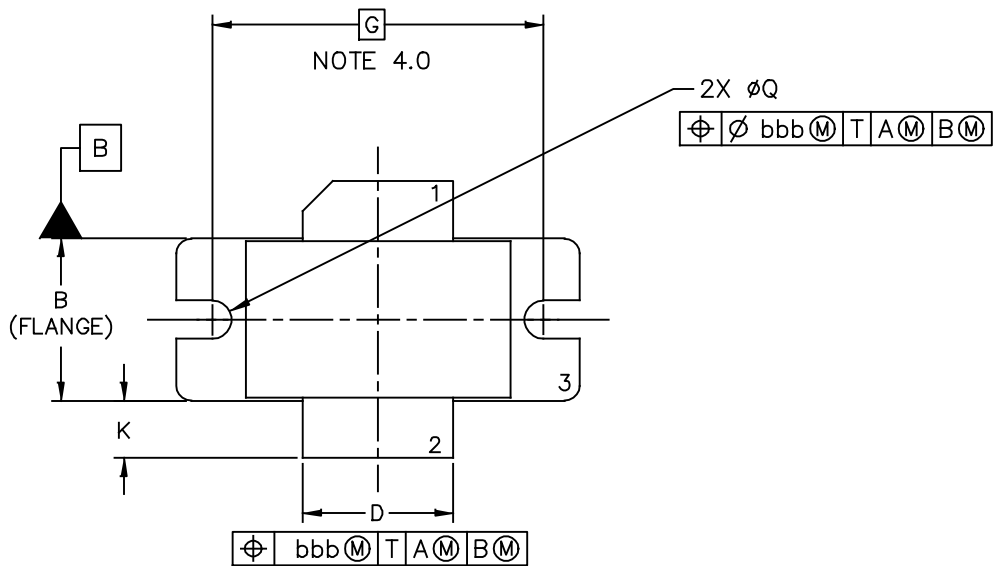
Test Impedances per Compression Level

f (MHz)		$Z_{\text{source}}$ $\Omega$	$Z_{\text{load}}$ $\Omega$
851	P1dB	1.46 - j2.70	3.02 + j0.04
865	P1dB	1.85 - j3.04	2.92 + j0.03
880	P1dB	2.20 - j3.31	2.85 + j0.70
895	P1dB	2.53 - j3.58	2.50 + j0.76

Figure 10. Pulsed CW Output Power versus Input Power @ 28 V



## PACKAGE DIMENSIONS

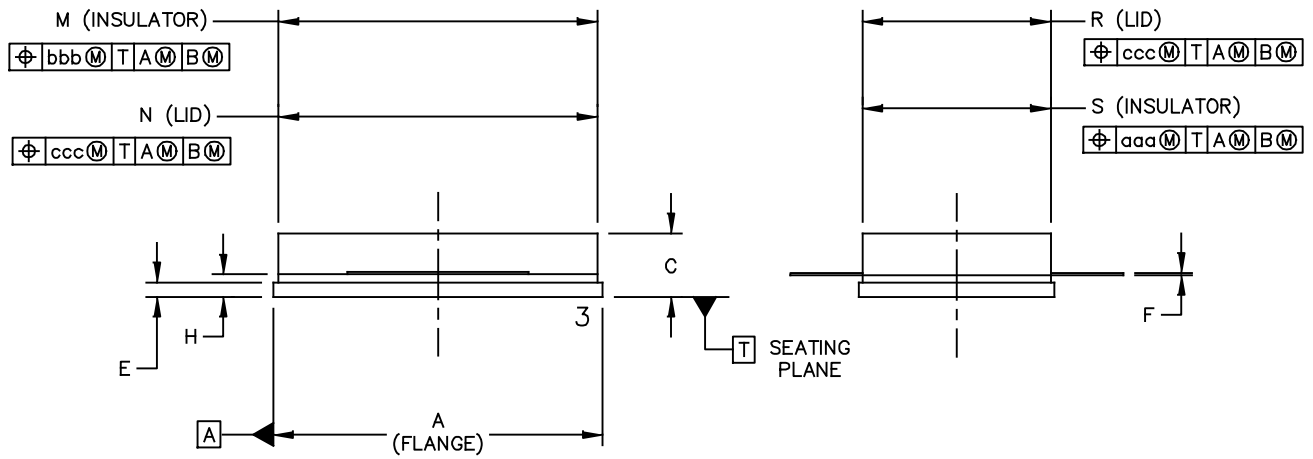
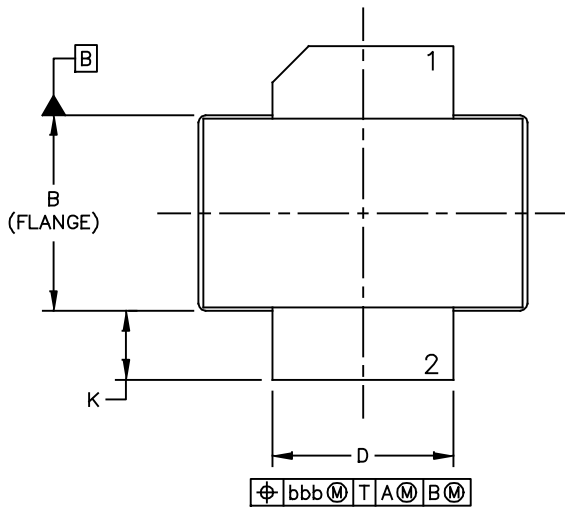


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NOTES:

- 1.0 DIMENSIONING AND TOLERANCING PER ANSI Y14.5M-1994.
- 2.0 CONTROLLING DIMENSION: INCH.
- 3.0 DIMENSION H IS MEASURED .030 (0.762) AWAY FROM PACKAGE BODY.
- 4.0 RECOMMENDED BOLT CENTER DIMENSION OF 1.16 (29.57) BASED ON M3 SCREW.

DIM	INCH		MILLIMETER		DIM	INCH		MILLIMETER	
	MIN	MAX	MIN	MAX		MIN	MAX	MIN	MAX
A	1.335	1.345	33.91	34.16	R	.515	-.525	13.08	- 13.34
B	.535	.545	13.59	13.84	S	.515	-.525	13.08	- 13.34
C	.147	.200	3.73	5.08	aaa	-	.007	-	0.178
D	.495	.505	12.57	12.83	bbb	-	.010	-	0.254
E	.035	.045	0.89	1.14	ccc	-	.015	-	0.381
F	.003	.006	0.08	0.15	-	-	-	-	-
G	1.100 BSC		27.94 BSC		-	-	-	-	-
H	.057	.067	1.45	1.70	-	-	-	-	-
K	.175	.205	4.45	5.21	-	-	-	-	-
M	.872	.888	22.15	22.56	-	-	-	-	-
N	.871	.889	22.12	22.58	-	-	-	-	-
Q	∅.118	∅.138	∅3.00	∅3.51	-	-	-	-	-
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3. DIMENSION H IS MEASURED .030 (0.762) AWAY FROM PACKAGE BODY.

DIM	INCH		MILLIMETER		DIM	INCH		MILLIMETER	
	MIN	MAX	MIN	MAX		MIN	MAX	MIN	MAX
A	.905	– .915	22.99	– 23.24	aaa	– .007	–	– 0.178	–
B	.535	– .545	13.59	– 13.84	bbb	– .010	–	– 0.254	–
C	.147	– .200	3.73	– 5.08	ccc	– .015	–	– 0.381	–
D	.495	– .505	12.57	– 12.83	–	–	–	–	–
E	.035	– .045	0.89	– 1.14	–	–	–	–	–
F	.003	– .006	0.08	– 0.15	–	–	–	–	–
H	.057	– .067	1.45	– 1.70	–	–	–	–	–
K	.170	– .210	4.32	– 5.33	–	–	–	–	–
M	.872	– .888	22.15	– 22.56	–	–	–	–	–
N	.871	– .889	22.12	– 22.58	–	–	–	–	–
R	.515	– .525	13.08	– 13.34	–	–	–	–	–
S	.515	– .525	13.08	– 13.34	–	–	–	–	–

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		STANDARD: NON–JEDEC			

## PRODUCT DOCUMENTATION, TOOLS AND SOFTWARE

Refer to the following documents, tools and software to aid your design process.

### Application Notes

- AN1955: Thermal Measurement Methodology of RF Power Amplifiers

### Engineering Bulletins

- EB212: Using Data Sheet Impedances for RF LDMOS Devices

### Software

- Electromigration MTTF Calculator
- RF High Power Model
- .s2p File

For Software and Tools, do a Part Number search at <http://www.freescale.com>, and select the “Part Number” link. Go to the Software & Tools tab on the part’s Product Summary page to download the respective tool.

## R5 TAPE AND REEL OPTION

R5 Suffix = 50 Units, 56 mm Tape Width, 13 inch Reel.

The R5 tape and reel option for MRF8S8260H and MRF8S8260HS parts will be available for 2 years after release of MRF8S8260H and MRF8S8260HS. Freescale Semiconductor, Inc. reserves the right to limit the quantities that will be delivered in the R5 tape and reel option. At the end of the 2 year period customers who have purchased these devices in the R5 tape and reel option will be offered MRF8S8260H and MRF8S8260HS in the R3 tape and reel option.

## REVISION HISTORY

The following table summarizes revisions to this document.

Revision	Date	Description
0	Jan. 2011	<ul style="list-style-type: none"><li>• Initial Release of Data Sheet</li></ul>
1	Feb. 2012	<ul style="list-style-type: none"><li>• Table 3, ESD Protection Characteristics, removed the word “Minimum” after the ESD class rating. ESD ratings are characterized during new product development but are not 100% tested during production. ESD ratings provided in the data sheet are intended to be used as a guideline when handling ESD sensitive devices, p. 2.</li><li>• Replaced Case Outline 465B-03, Issue D, with 465B-04, Issue F, p. 1, 9-10. Deleted Style 1 pin note on Sheet 2. On Sheet 2, changed dimension B in mm from 13.6-13.8 to 13.59-13.84, changed dimension H in mm from 1.45-1.7 to 1.45-1.70, changed dimension K in mm from 4.44-5.21 to 4.45-5.21, changed dimension M in mm from 22.15-22.55 to 22.15-22.56, changed dimension N in mm from 19.3-22.6 to 22.12-22.58, changed dimension Q in mm from 3-3.51 to 3.00-3.51, changed dimension R and S in mm from 13.1-13.3 to 13.08-13.34.</li><li>• Replaced Case Outline 465C-02, Issue D, with 465C-03, Issue E, p. 1, 11-12. Deleted Style 1 pin note on Sheet 2. On Sheet 2, changed dimension B in mm from 13.6-13.8 to 13.59-13.84, changed dimension H in mm from 1.45-1.7 to 1.45-1.70, changed dimension M in mm from 22.15-22.55 to 22.15-22.56, changed dimension N in mm from 19.3-22.6 to 22.12-22.58, changed dimension R and S in mm from 13.1-13.3 to 13.08-13.34.</li></ul>

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